

The MIC MRA International Workshop in 2016

Draft

Day 1, March 2, 2016

Overview: Regulations and Certification System of Japan, EU and U.S.

9:30	<i>Show up</i>
10:00	<i>Instruction Guidance</i>
10:05	<i>Opening Addresses</i> Katsuya WATANABE (Director-General of the Radio Department, MIC)
10:15	<i>The Latest Information of FCC Technical Requirements</i> George TANNAHILL (Electronics Engineer, Federal Communications Commission)
10:55	<i>Accreditations and Designations of U.S. RCBs</i> Ramona J. SAAR (Program Manager, National Institute of Standards and Technology)
11:35	<i>Coffee Break</i>
11:50	<i>Introduction Technical Requirements in Brazil</i> Fernando Borges BOUÇAS (Grupo IBRACE-ICBr)
12:30	<i>Lunch</i>
14:00	<i>Current Status and Issues of the Japanese ICT Policy</i> Satoshi MURAKAMI (Director of Certification Promotion Office, MIC)
14:30	<i>The Latest Information of Regulations and Certification Systems of Radio Equipment</i> Chikara IMAI (Deputy Director, Certification Promotion Office, MIC)
15:00	<i>The Latest Information of Regulations and Certification Systems of Telecommunication Equipment</i> Mitsuhiro KAWASAKI (Deputy Director, Radio Environment Division, MIC)
15:30	<i>Coffee break</i>
16:00	<i>The Latest Information of RE Directive, EU</i> Jan COENRAADS (Secretary, The Radio Equipment Directive Compliance Association)
16:40	<i>Closing</i>

Day 2, March 3, 2016

Case Study: Operations and Maintenances of Testing Laboratories

9:30	<i>Show up</i>
10:00	<i>Introduction Today's Case Study</i> Nobuhiro NAKANISHI (Public Relations WG, ICCJ)
10:10	<i>Abilities and the Audit System of Testing Laboratories</i> Roger SHENG (Chief, Taiwan Accreditation Foundation)
10:50	<i>Performances and Calibrations of Measurement Equipment</i> Christian REIMER (Rohde & Schwarz GmbH & Co. KG)
11:30	<i>Coffee Break</i>
11:45	<i>Educational Activities of TCB council</i> Chris HARVEY (Executive Director, TCB Council)
12:30	<i>Lunch</i>
14:00	<i>Fast SAR – Concept, Implementation and Results of Validation and Verification.</i> Niels KUSTER (Director of IT'IS Foundation and Professor of ETH Zurich)
14:35	<i>IEC 62209-3 Vector-Probe Array Systems: Fast SAR</i> Benoit DERAT (President, ART-Fi SAS)
15:10	<i>Coffee Break</i>
15:25	<i>Summary and Q&A</i>
16:00	<i>Closing</i>
16:30	<i>The Japan, EU and U.S. Registered Certification Body Conference</i>